

TSEK03: Radio Frequency Integrated Circuits (RFIC)

Lecture 3a: Background

Ted Johansson, EKS, ISY

ted.johansson@liu.se

Background: Overview

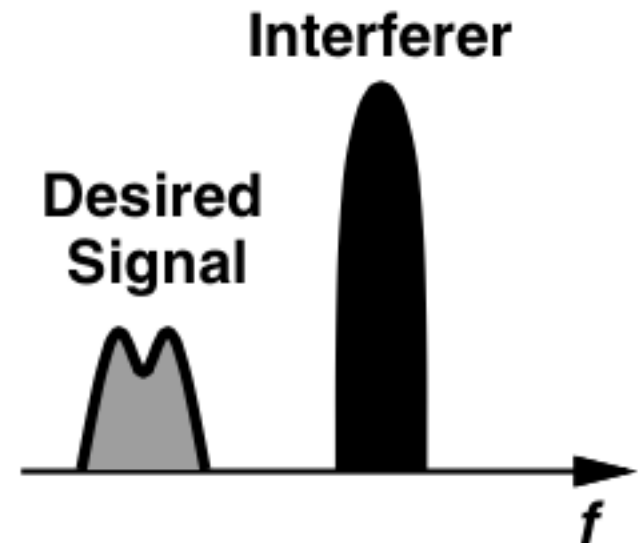
- Razavi:
 - Chapter 2.2 Effects of nonlinearity
(mostly repetition from TSEK02)
 - Chapter 2.5 Matching
 - Chapter 2.6 Scattering parameters
- Lee:
 - Chapter 7 Smith chart and s-parameters

2.2 Linearity

- For a nonlinear device:

$$i(V_{DC} + v) \approx a_0 + a_1v + a_2v^2 + a_3v^3 + \dots$$

- When strong signals are received, the LNA should remain linear
- Typically, weak signals are received in the presence of a strong interference. Linearity is important to suppress intermodulation distortion.



2.2.1 Harmonic Distortion

- Consider a nonlinear system

$$x(t) \rightarrow \left[\text{Nonlinear System} \right] y(t) = \alpha_1 V_{in} + \alpha_2 V_{in}^2 + \alpha_3 V_{in}^3 + \dots$$

Let us apply a single-tone ($A \cos \omega t$) to the input and calculate the output:

$$\begin{aligned} y(t) &= \alpha_1 A \cos \omega t + \alpha_2 A^2 \cos^2 \omega t + \alpha_3 A^3 \cos^3 \omega t \\ &= \alpha_1 A \cos \omega t + \frac{\alpha_2 A^2}{2} (1 + \cos 2\omega t) + \frac{\alpha_3 A^3}{4} (3 \cos \omega t + \cos 3\omega t) \\ &= \underbrace{\frac{\alpha_2 A^2}{2}}_{\text{DC}} + \underbrace{\left(\alpha_1 A + \frac{3\alpha_3 A^3}{4} \right)}_{\text{Fundamental}} \cos \omega t + \underbrace{\frac{\alpha_2 A^2}{2}}_{\text{Second Harmonic}} \cos 2\omega t + \underbrace{\frac{\alpha_3 A^3}{4}}_{\text{Third Harmonic}} \cos 3\omega t. \end{aligned}$$

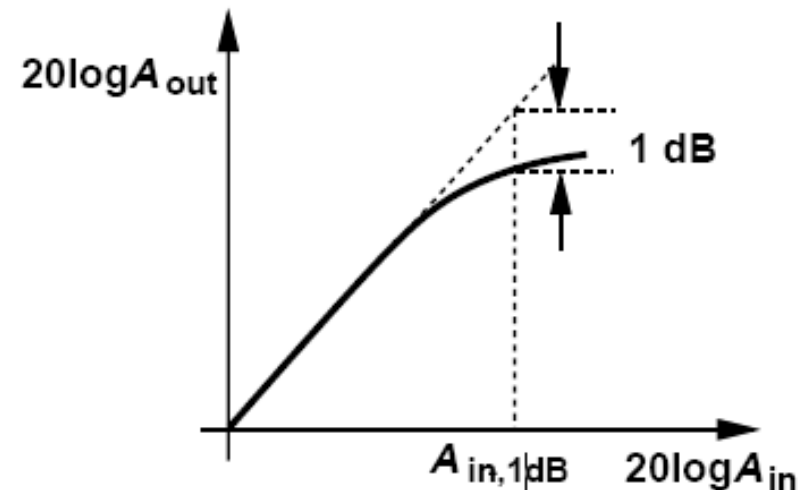
2.2.2 Gain compression

- If sign of α_1 and α_3 are opposite then the point in which the output falls below its ideal value by 1 dB is called 1-dB compression point or P-1dB:

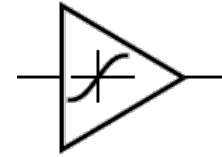
$$20 \log \left| \alpha_1 + \frac{3}{4} \alpha_3 A_{in,1dB}^2 \right| = 20 \log |\alpha_1| - 1 \text{ dB}.$$

$$A_{in,1dB} = \sqrt{0.145 \left| \frac{\alpha_1}{\alpha_3} \right|}.$$

The P-1dB point correlates well to loss of linear behavior, getting out-of-spec in standards (EVM, ACPR, etc.) so for linear applications, operation beyond this point is useless.



2.2.4 Intermodulation



- If a two-tone signal is applied to a non-linear device:

$$v = A[\cos(\omega_1 t) + \cos(\omega_2 t)]$$

$$i(V_{DC} + v) \approx c_0 + c_1 v + c_2 v^2 + c_3 v^3 + \dots$$

- By combining these equations we get several tones:**

- **DC and fundamental tones**

$$(c_0 + c_2 A^2) + (c_1 A + \frac{9}{4} c_3 A^3) [\cos(\omega_1 t) + \cos(\omega_2 t)]$$

- **Second and third harmonic terms**

$$(\frac{c_2 A^2}{2}) [\cos(2\omega_1 t) + \cos(2\omega_2 t)] + (\frac{c_3 A^3}{4}) [\cos(3\omega_1 t) + \cos(3\omega_2 t)]$$

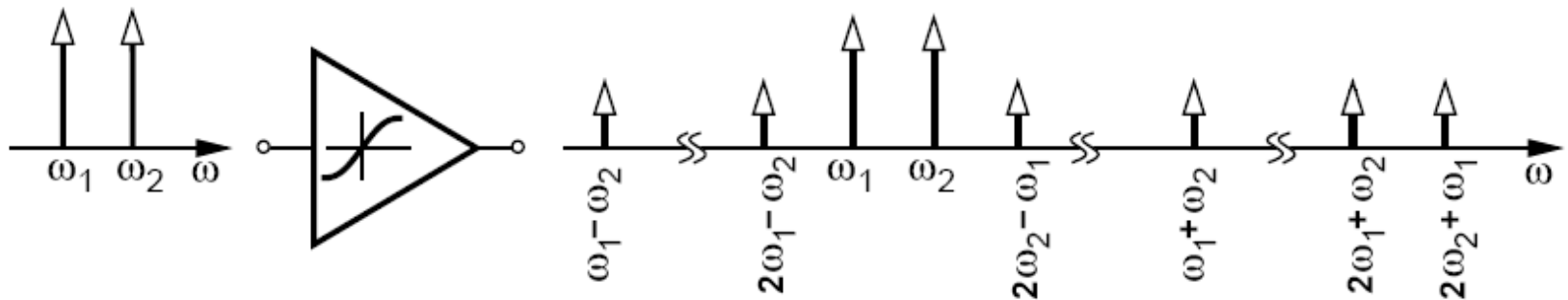
- **Second order intermodulation (IM) products**

$$(\frac{c_2 A^2}{2}) [\cos(\omega_1 + \omega_2)t + \cos(\omega_1 - \omega_2)t]$$

- **Third order IM products**

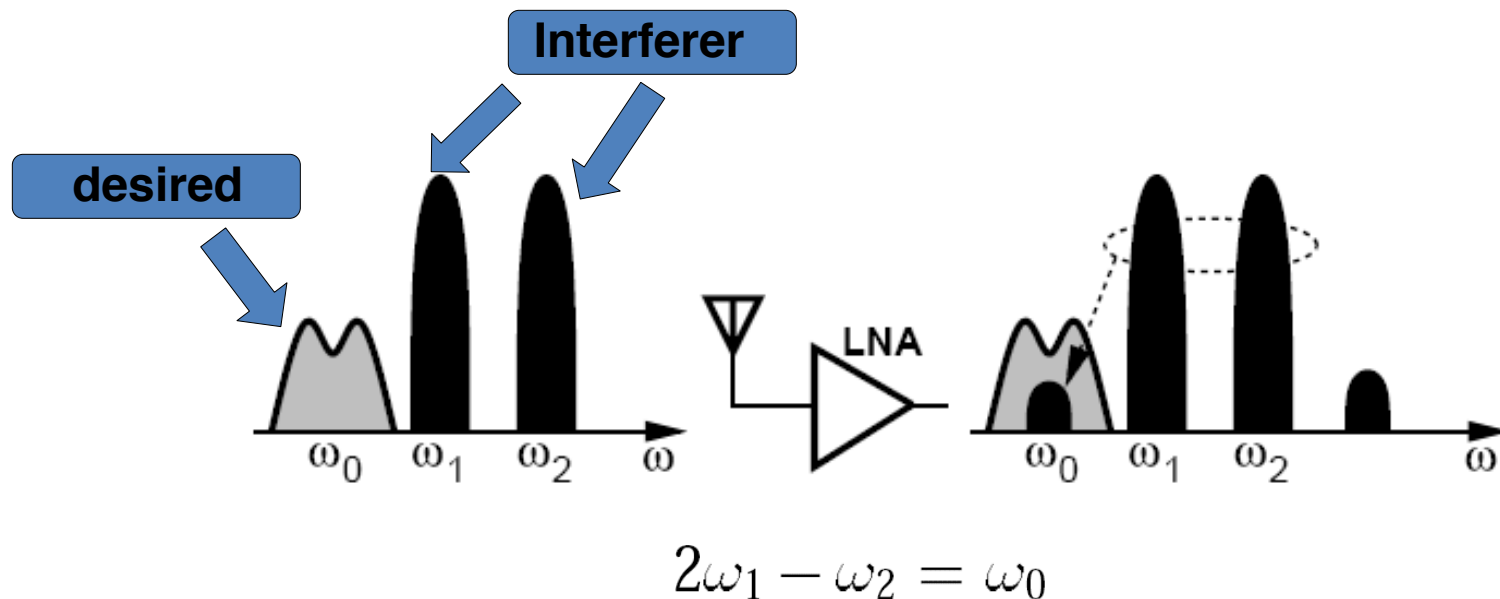
$$(\frac{3c_3 A^3}{4}) [\cos(2\omega_1 + \omega_2)t + \cos(2\omega_1 - \omega_2)t + \cos(\omega_1 - 2\omega_2)t + \cos(\omega_1 + 2\omega_2)t]$$

Intermodulation



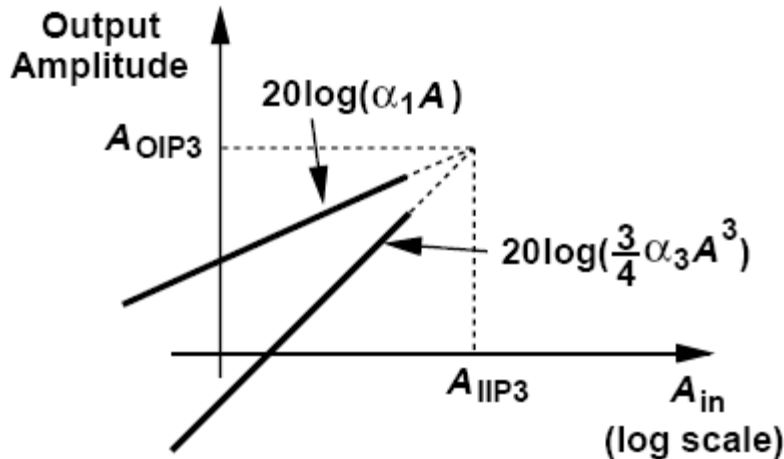
Intermodulation

- Typically, weak signals are received in the presence of a strong interference. This might cause intermodulation distortion.



Third-Order Intercept Point (IP3)

- Input-referred third-order intercept point (IIP3) is calculated by setting the IM3 products equal to the amplitude of the fundamental tone ($A_1=A_2=A$):



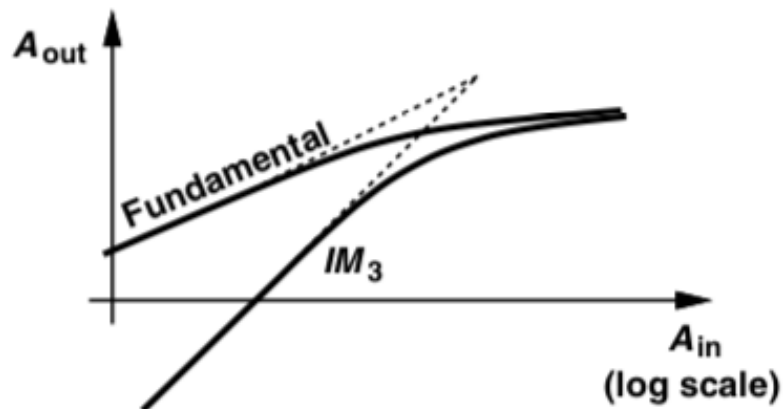
$$|\alpha_1 A_{IIP3}| = \left| \frac{3}{4} \alpha_3 A_{IIP3}^3 \right|$$

$$A_{IIP3} = \sqrt{\frac{4}{3} \left| \frac{\alpha_1}{\alpha_3} \right|}$$

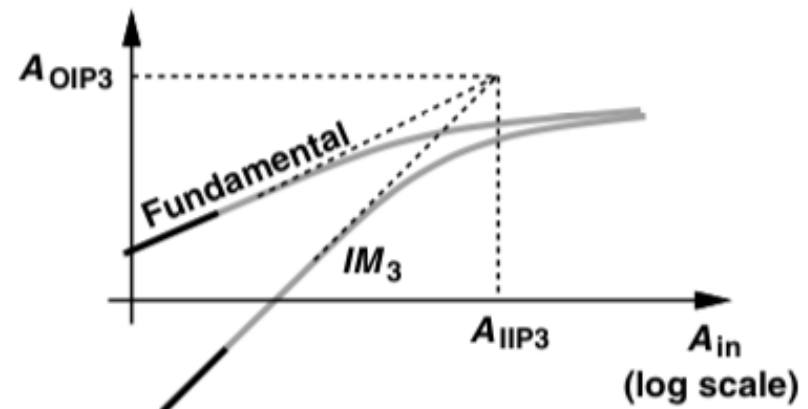
$$\frac{A_{IIP3}}{A_{1dB}} = \sqrt{\frac{4}{0.435}} \approx 9.6 \text{ dB.}$$

IP3: measurement

- Circuits are non-linear at high power levels
- Measured at low power levels (check the slopes!), extrapolate!



(a)

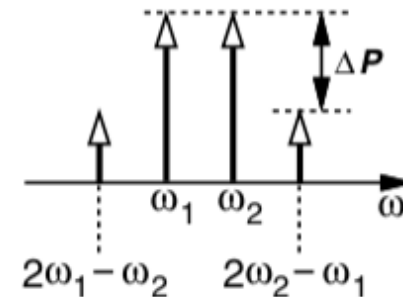
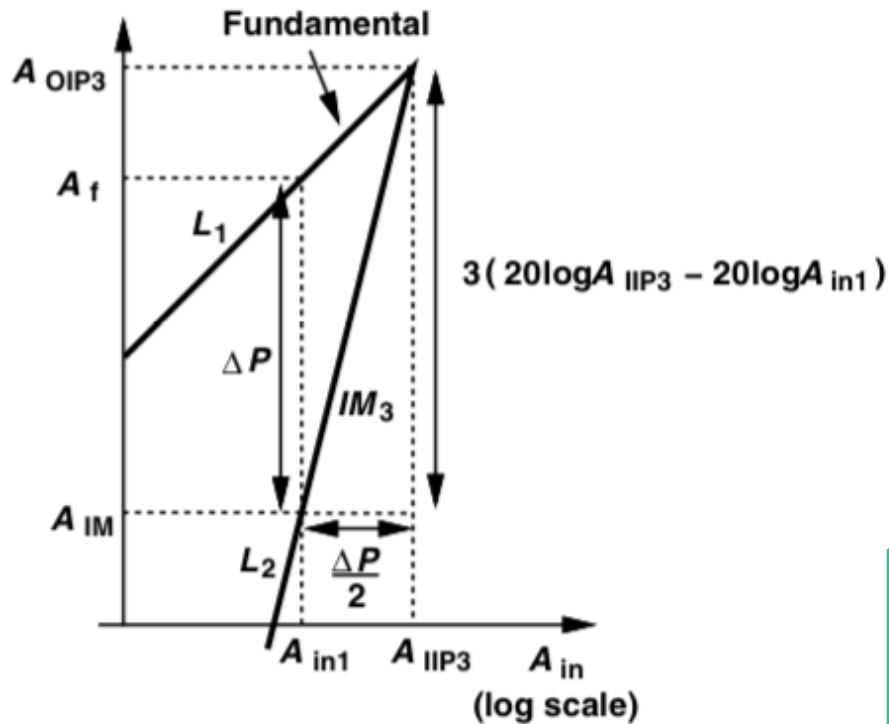


(b)

Figure 2.21 (a) Actual behavior of nonlinear circuits, (b) definition of IP_3 based on extrapolation.

IP3: measurement

- Shortcut technique if slopes are OK.



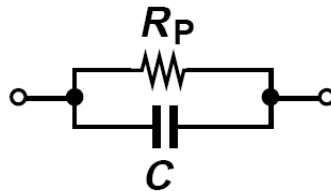
$$IIP3|_{dBm} = \frac{\Delta P|_{dB}}{2} + P_{in}|_{dBm}$$

2.5 Passive impedance transformation

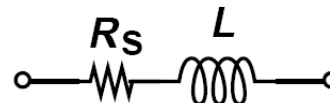
- a.k.a. *Matching networks*
- 2.5.1 Quality Factor, Q , indicates how close to ideal an energy-storing device is.



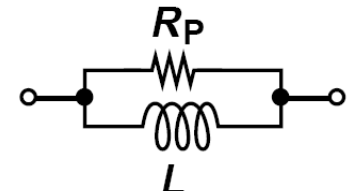
$$Q_S = \frac{1}{\frac{C\omega}{R_S}}$$



$$Q_P = \frac{R_P}{\frac{1}{C\omega}}$$



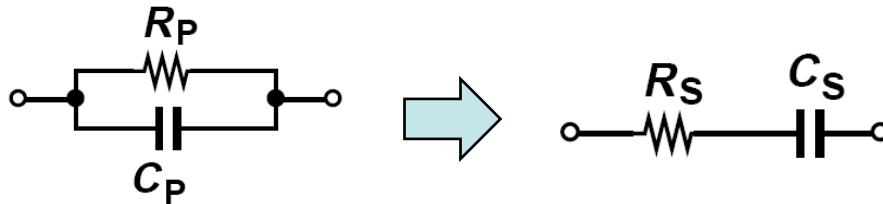
$$Q_S = \frac{L\omega}{R_S}$$



$$Q_P = \frac{R_P}{L\omega}$$

Parallel-to-series conversion

- Series-to-Parallel Conversion: will retain the value of the capacitor but raises the resistance by a factor of Q_s^2
- Parallel-to-Series Conversion: will reduce the resistance by a factor of Q_p^2



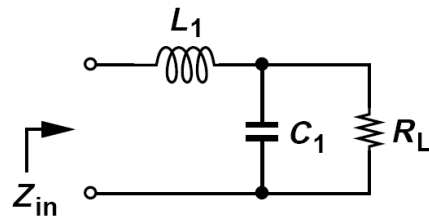
$$R_S = \frac{R_P}{Q_P^2}$$

$$C_S = C_P$$

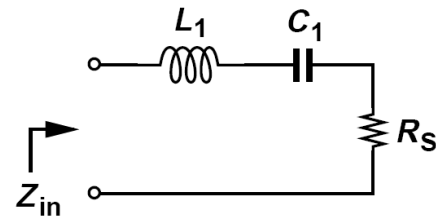
valid if $Q_s^2 \gg 1$
("relative accurate")

Basic matching networks

- Load resistance transformed to a lower value ($Z_{in} < R_L$):



(a)



(b)

$$Z_{in}(j\omega) = \frac{R_L(1 - L_1 C_1 \omega^2) + j L_1 \omega}{1 + j R_L C_1 \omega}$$

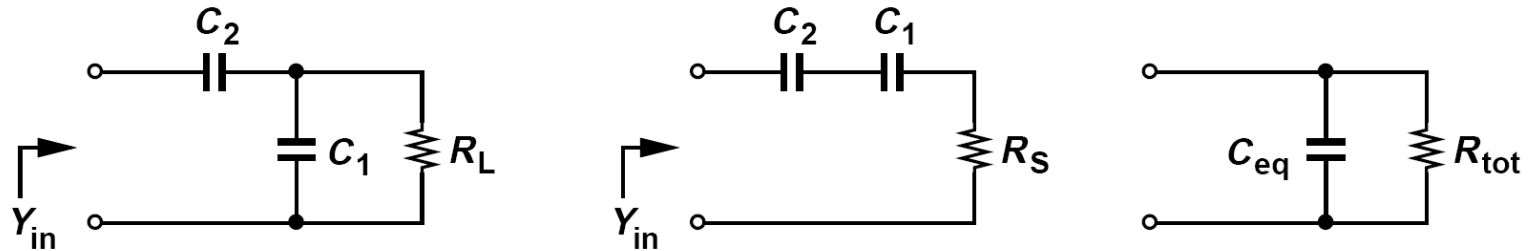
$$\begin{aligned} \operatorname{Re}\{Z_{in}\} &= \frac{R_L}{1 + R_L^2 C_1^2 \omega^2} \\ &= \frac{R_L}{1 + Q_P^2}, \end{aligned}$$

$$Q_P^2 \gg 1$$

$$\begin{aligned} \operatorname{Re}\{Z_{in}\} &\approx \frac{1}{R_L C_1^2 \omega^2} \\ L_1 &= \frac{1}{C_1 \omega^2}. \end{aligned}$$

$$\begin{aligned} L_1 &= \frac{R_L^2 C_1}{1 + R_L^2 C_1^2 \omega^2} \\ &= \frac{R_L^2 C_1}{1 + Q_P^2}. \end{aligned}$$

Transfer a resistance to a higher value



$$Q^2 \gg 1 \quad R_S \approx [R_L(C_1\omega)^2]^{-1} \quad C_S \approx C_1$$

Note that any imaginary component (often capacitance) must first be cancelled by an inductor at the input.

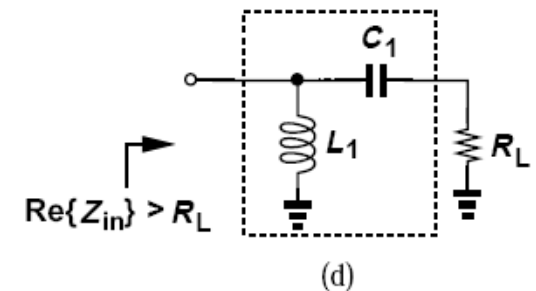
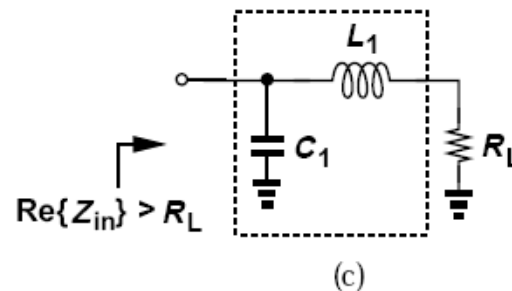
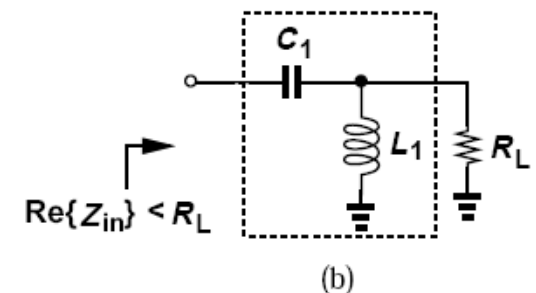
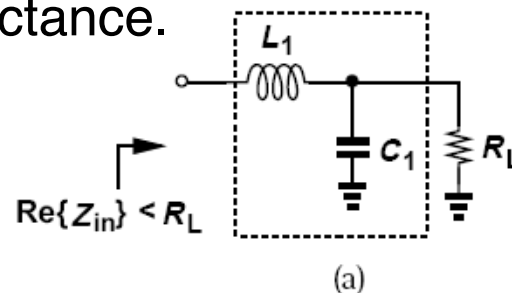
L sections

a) C_1 transforms R_L to a smaller series value and L_1 cancels C_1 .

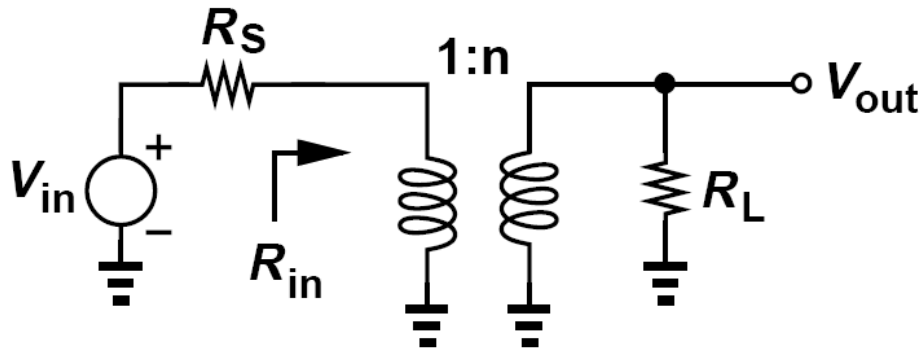
b) L_1 transforms R_L to a smaller series value while C_1 resonates with L_1 .

c) L_1 transforms R_L to a larger parallel value and C_1 cancels the resulting parallel inductance.

d) same as c)

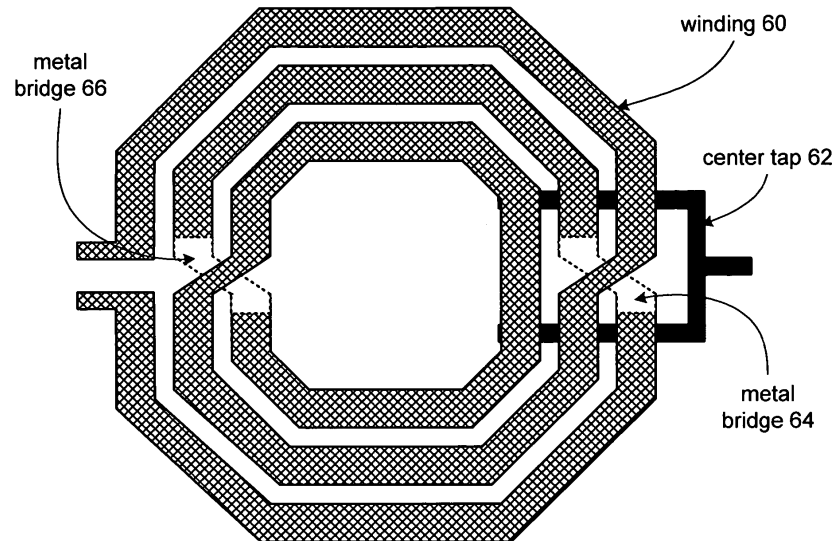


Impedance matching by transformers



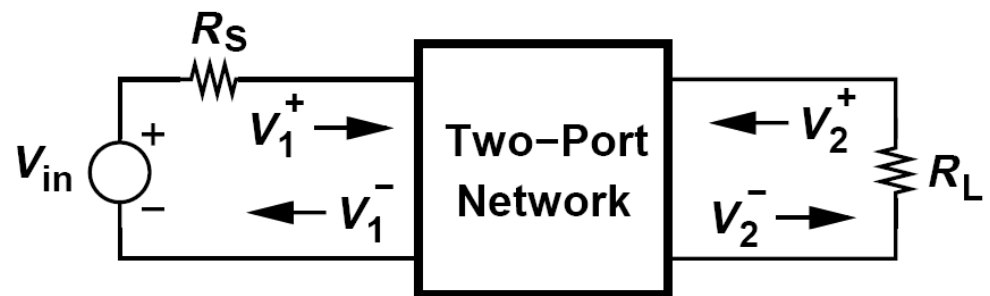
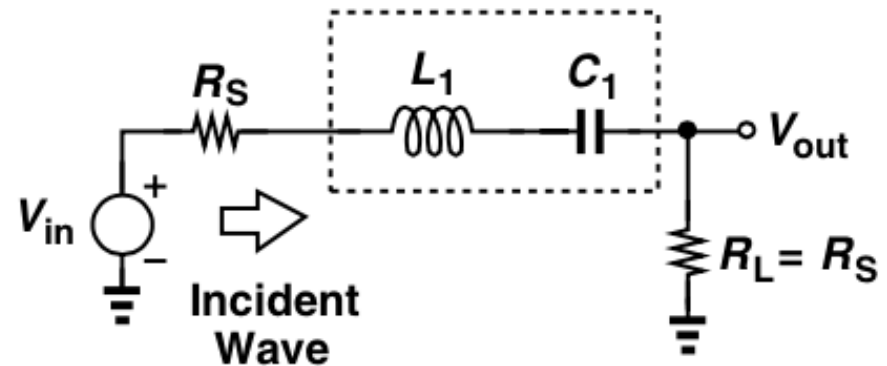
$$V_{in}^2 / R_{in} = n^2 V_{in}^2 / R_L$$

$$R_{in} = R_L / n^2$$



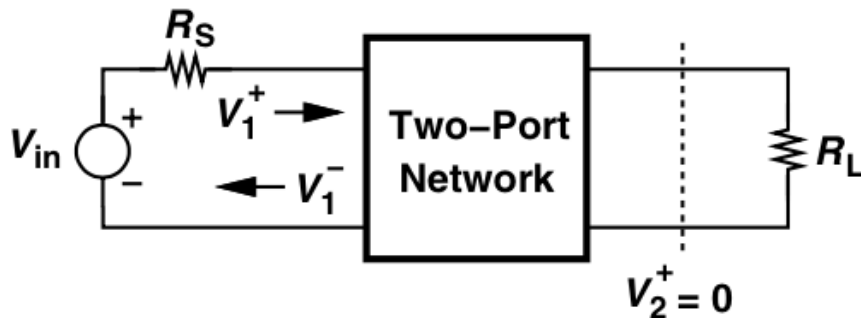
2.6 Scattering (S-) parameters

- Microwave circuits (transfer of power) vs. analog design (voltage). Affects tools, methods, models, etc.
- z-parameters require open/short termination for measurements which are hard to obtain for high frequencies (couple of 100 MHz).
- With S-parameters (scattering or power wave) terminations (50 Ohms) are instead used for measurements



S-parameters

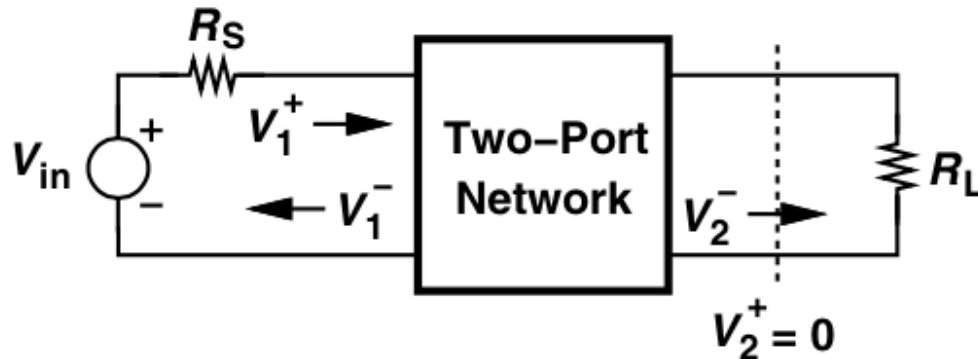
- S_{11} is the ratio of the reflected and incident waves at the input port when the reflection from R_L (i.e., V_2^+) is zero. Represents the input matching (but reflection, not impedance!).



$$S_{11} = \frac{V_1^-}{V_1^+} \big|_{V_2^+ = 0}.$$

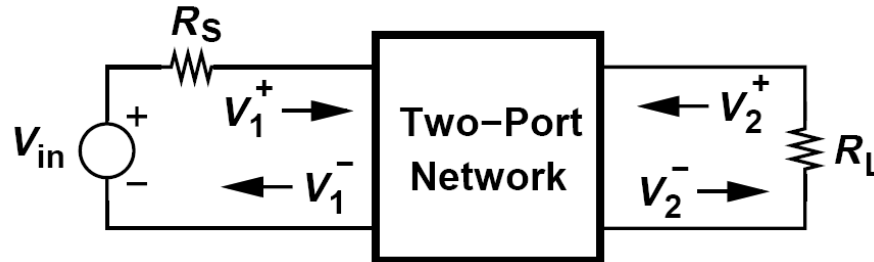
S-parameters

- S_{21} is the ratio of the wave incident on the load to that going to the input when the reflection from R_L is zero. Represents the gain.



$$S_{21} = \frac{V_2^-}{V_1^+} \big|_{V_2^+ = 0}.$$

s-parameters



Input matching

Reverse isolation

$$V_1^- = S_{11}V_1^+ + S_{12}V_2^+$$

$$V_2^- = S_{21}V_1^+ + S_{22}V_2^+.$$

Gain

Output matching

complex = Re+Im or A+Ph, and frequency dependent

S and Z parameters

$$Z_{11} = \frac{((1 + S_{11})(1 - S_{22}) + S_{12}S_{21})}{\Delta_S} Z_0$$

$$Z_{12} = \frac{2S_{12}}{\Delta_S} Z_0$$

$$Z_{21} = \frac{2S_{21}}{\Delta_S} Z_0$$

$$Z_{22} = \frac{((1 - S_{11})(1 + S_{22}) + S_{12}S_{21})}{\Delta_S} Z_0$$

Where

$$\Delta_S = (1 - S_{11})(1 - S_{22}) - S_{12}S_{21}$$

The input impedance of a two-port network is given by:

$$Z_{in} = Z_{11} - \frac{Z_{12}Z_{21}}{Z_{22} + Z_L}$$

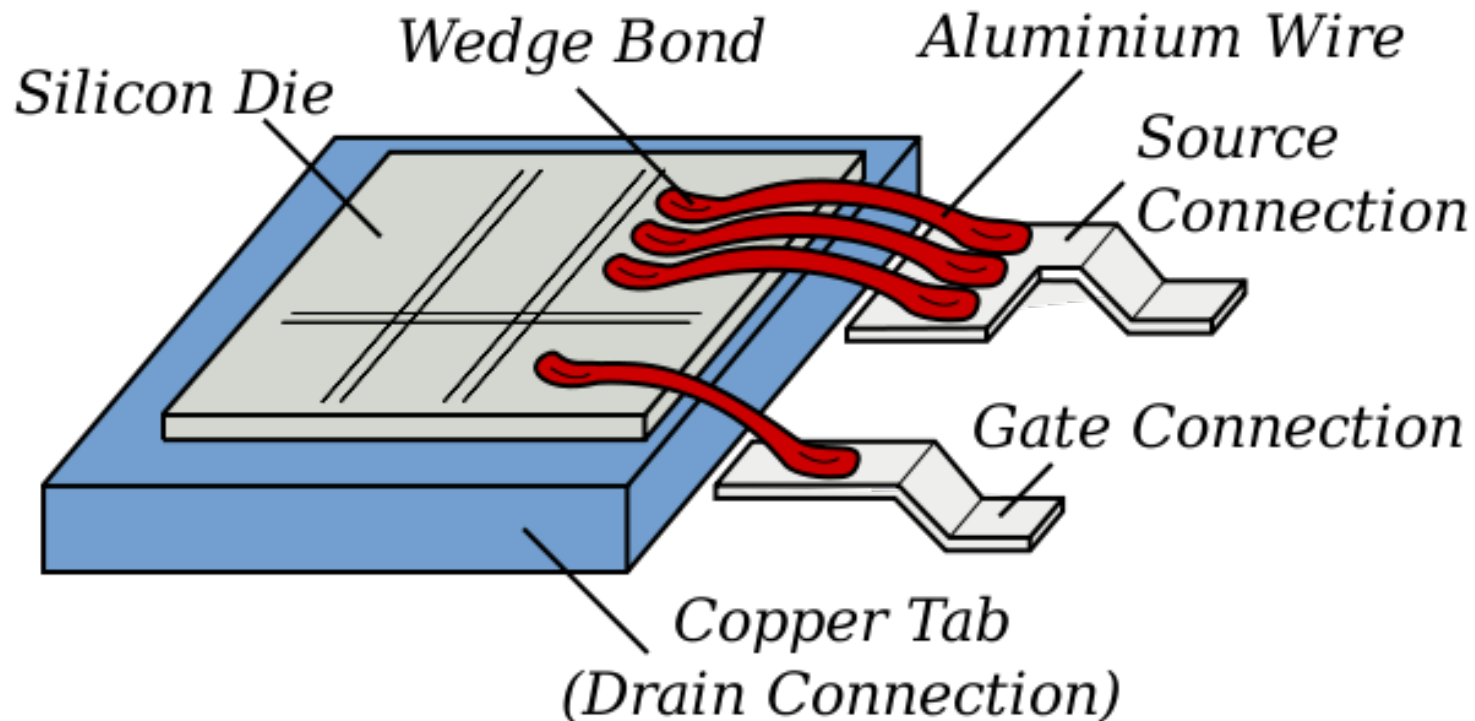
where Z_L is the impedance of the load connected to port two.

S-parameters

- S-parameters are typically measured using a network analyzer
- data is often displayed using Smith-charts

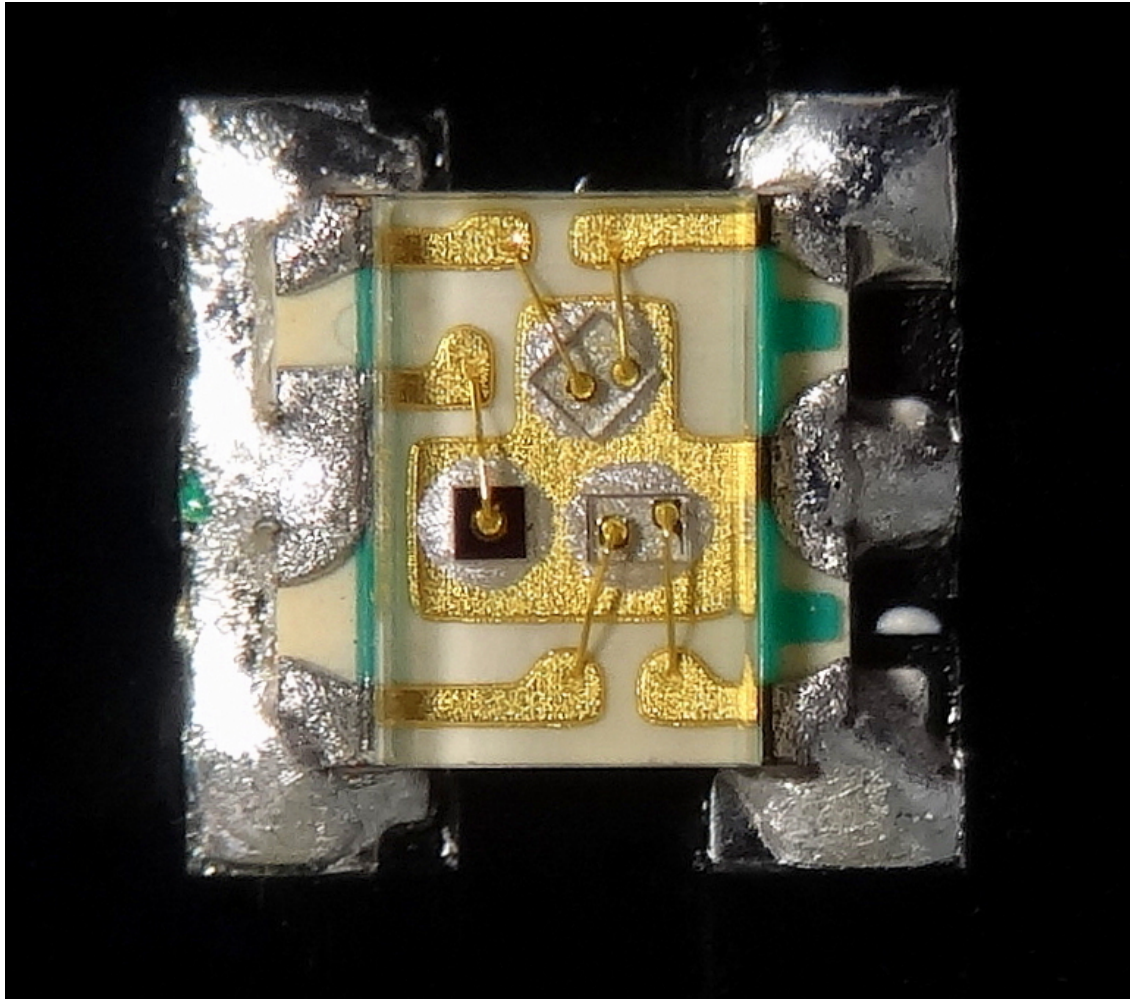


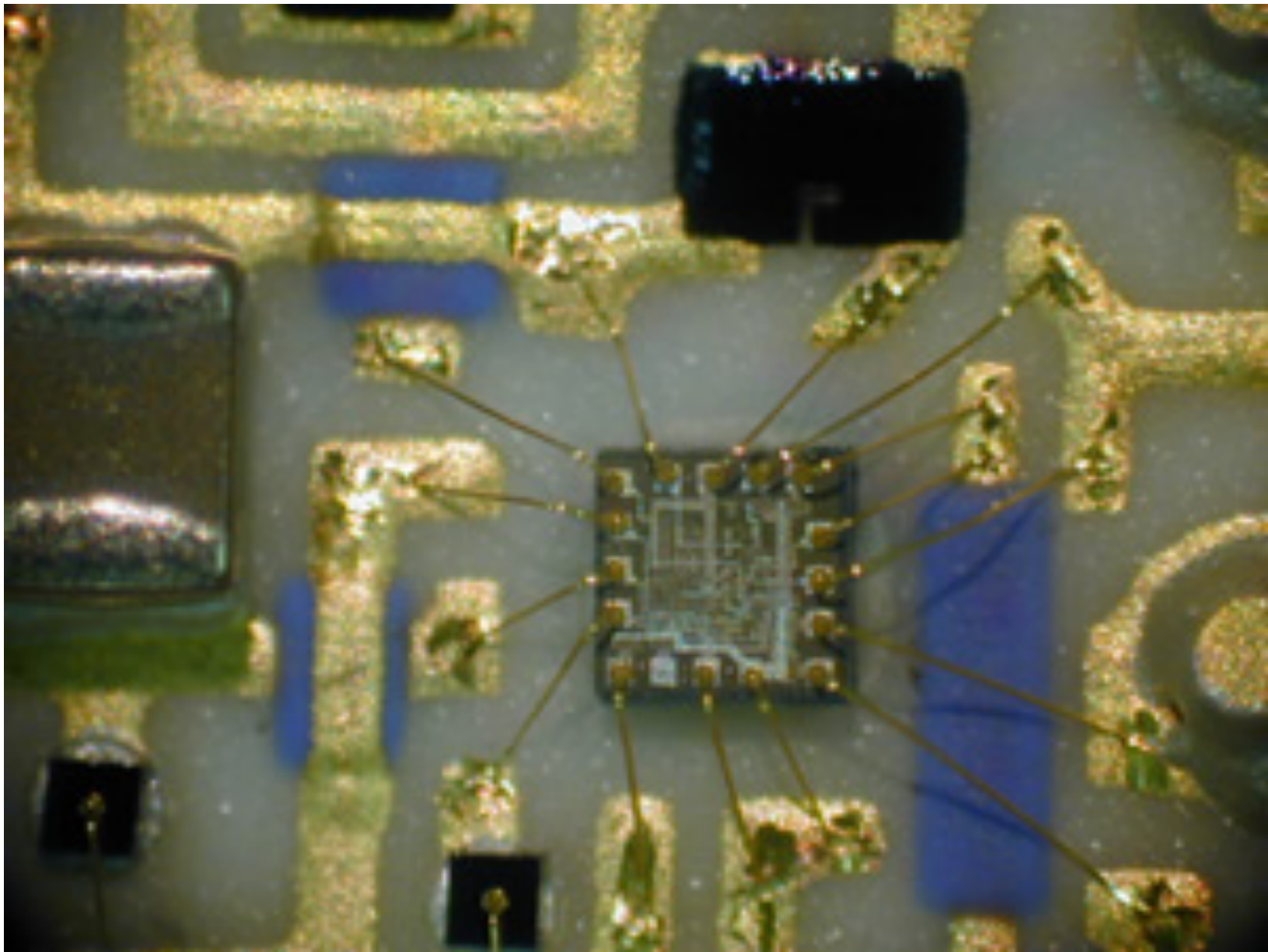
RF-IC packaging and measurements



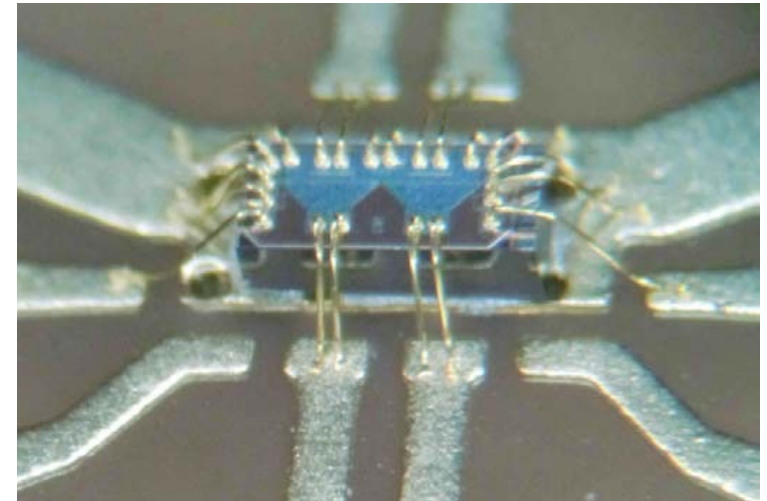
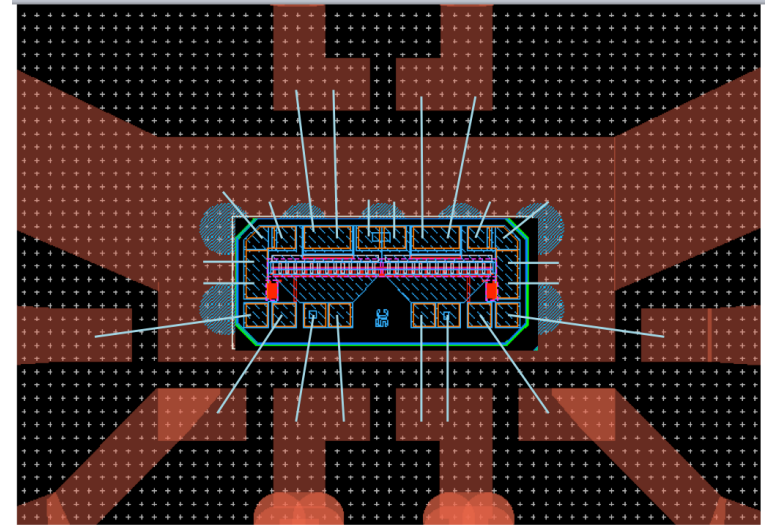
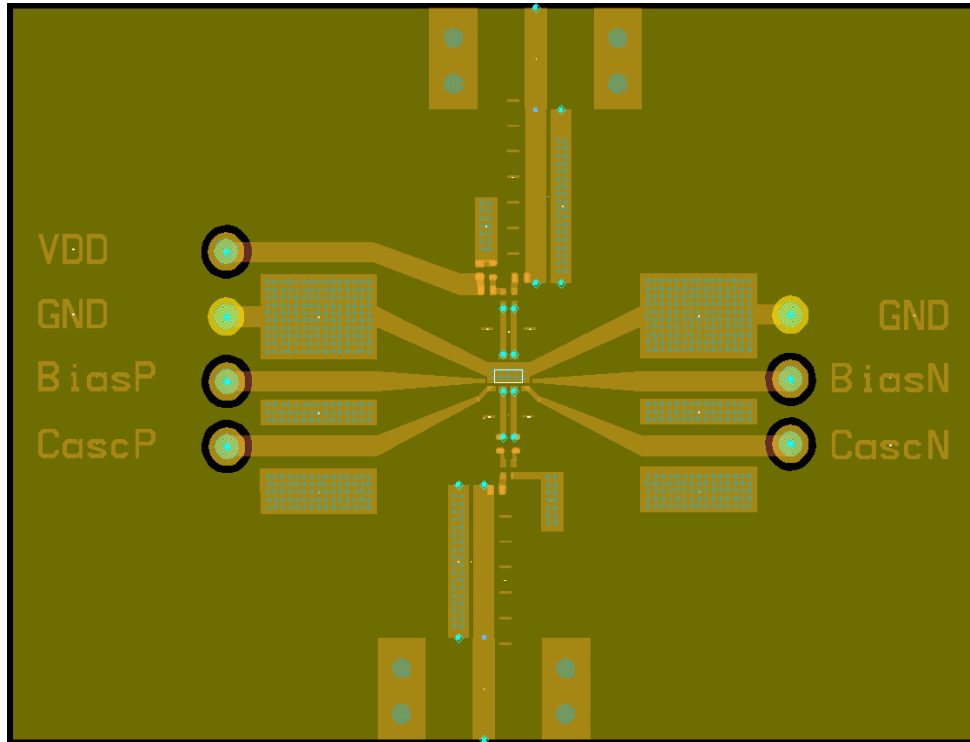
[Wikipedia]

RF-IC packaging

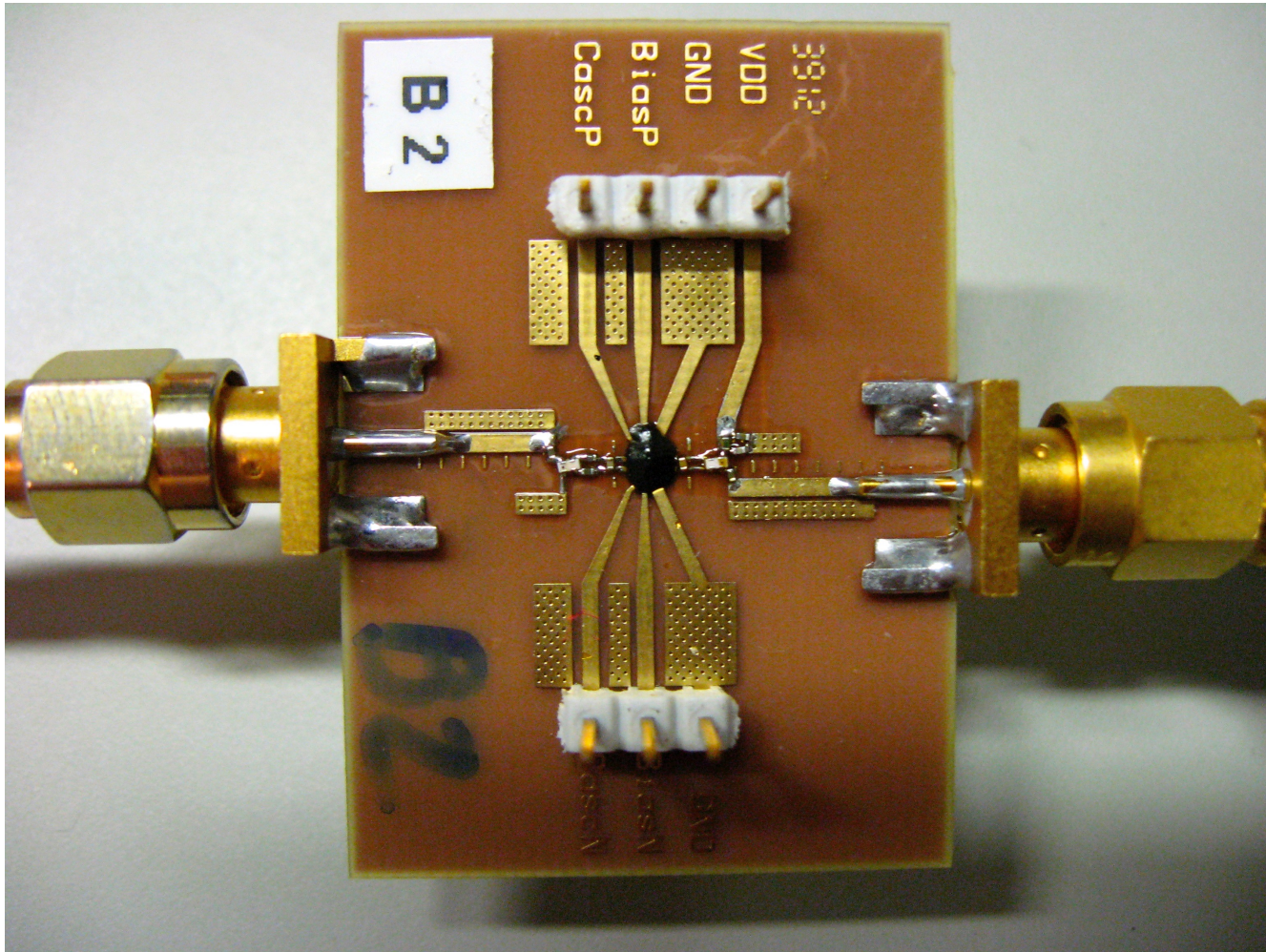




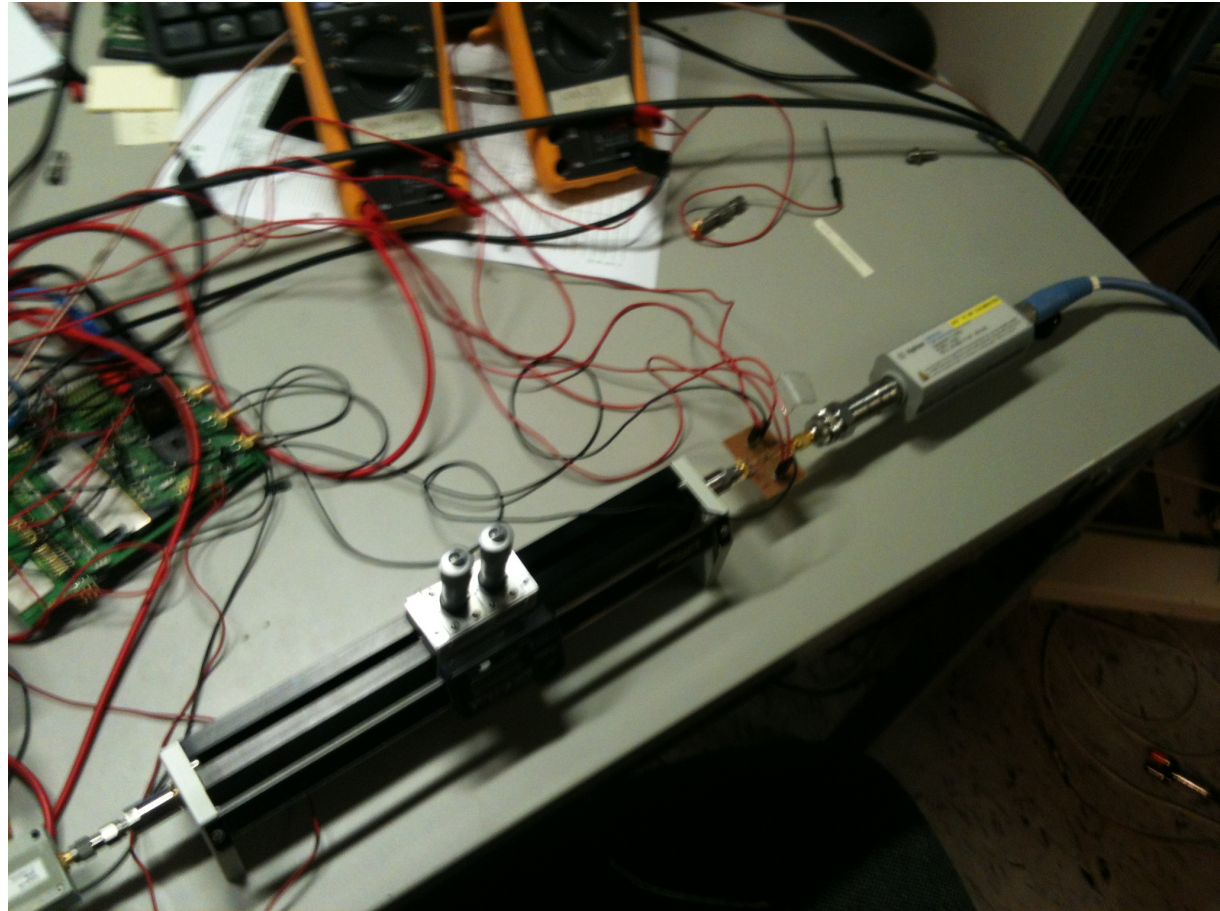
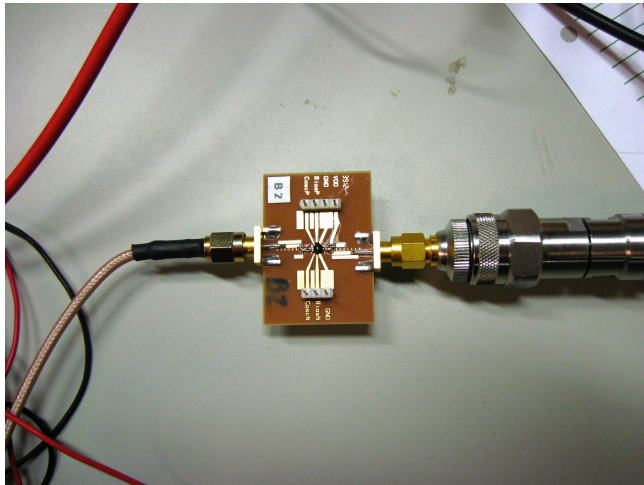
PCB and Bonding

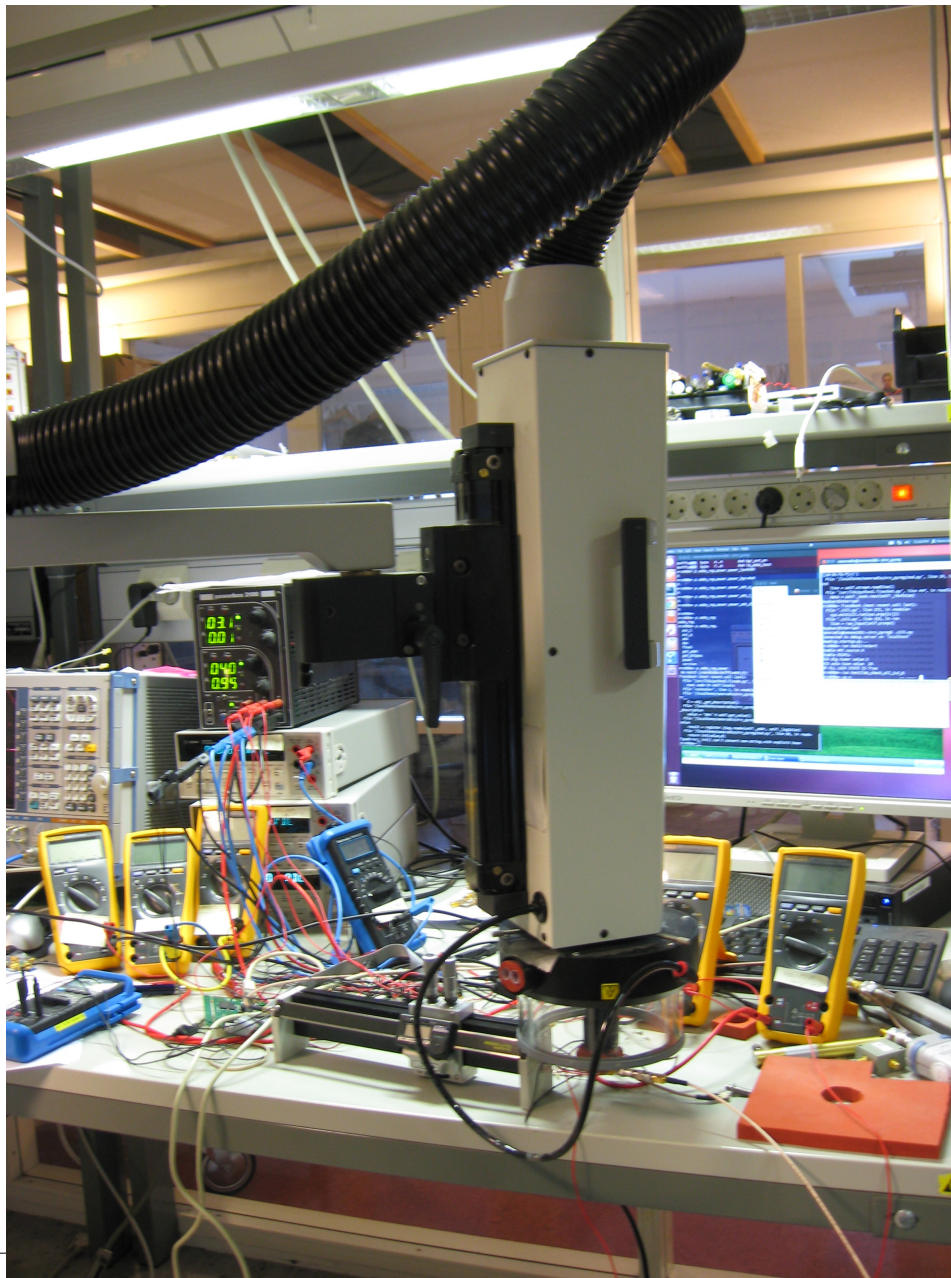


Mounted/soldered PCB

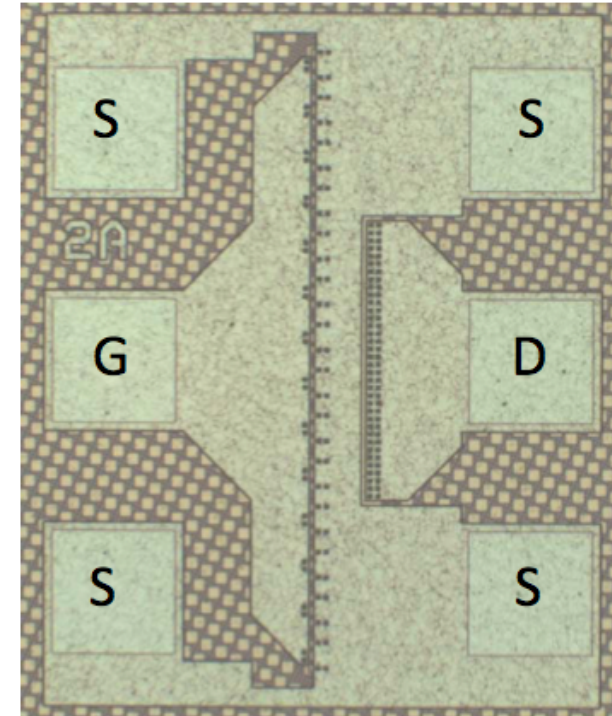
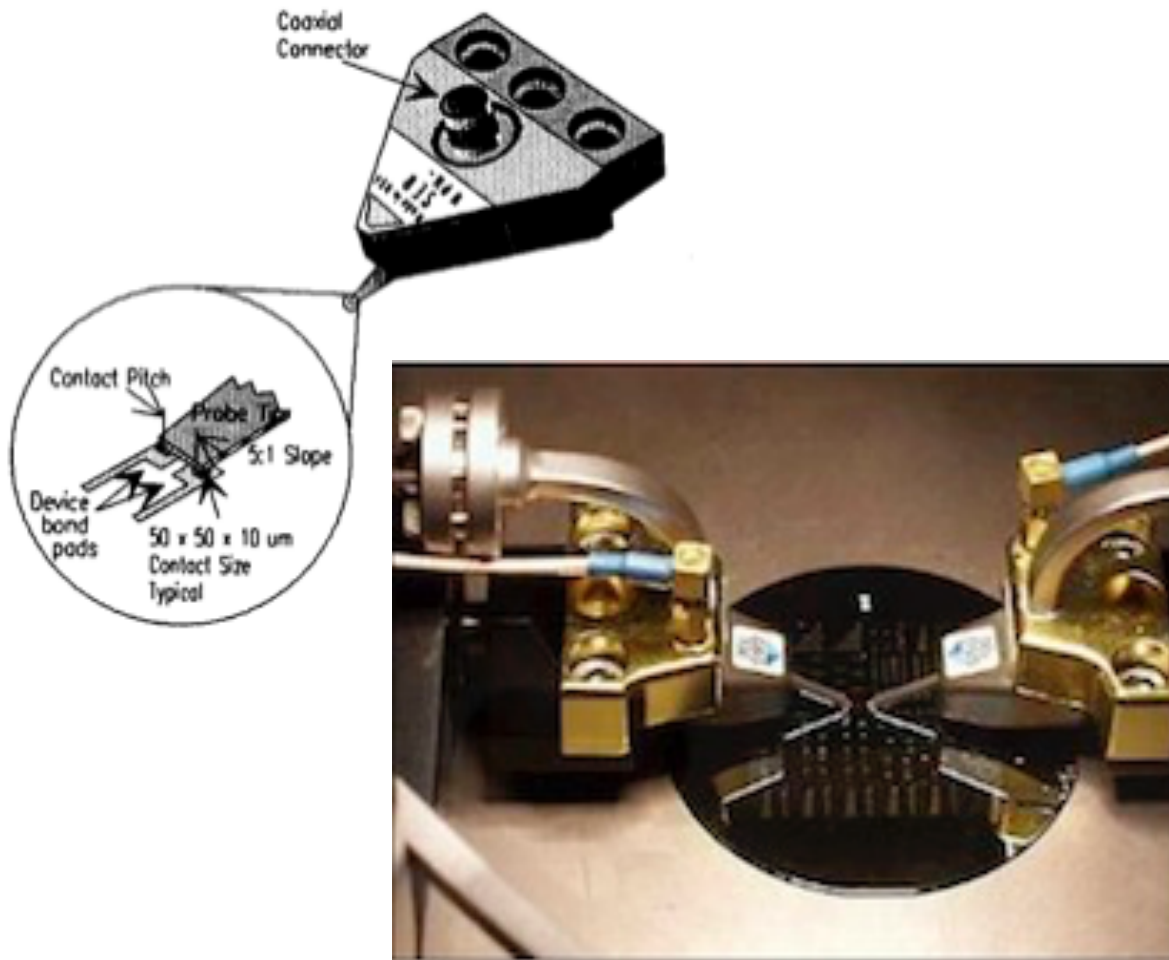


PCB measurements





On-wafer measurements



Summary: S-parameters

- S-parameters are a powerful way to describe a linear electrical network at high frequency
- S-parameters change with frequency, load impedance, source impedance, network
- S_{11} is the reflection coefficient
- S_{21} describes the forward transmission coefficient (corresponds to gain)
- S-parameters have both magnitude and phase information
- S-parameters may describe large and complex networks

Stability (no self-oscillations)

- Stability of an RF circuit can be checked by Stern (Rollett) stability factor which is based on S-parameters:

$$K = \frac{1 + |\Delta|^2 - |S_{11}|^2 - |S_{22}|^2}{2|S_{12}S_{21}|}$$

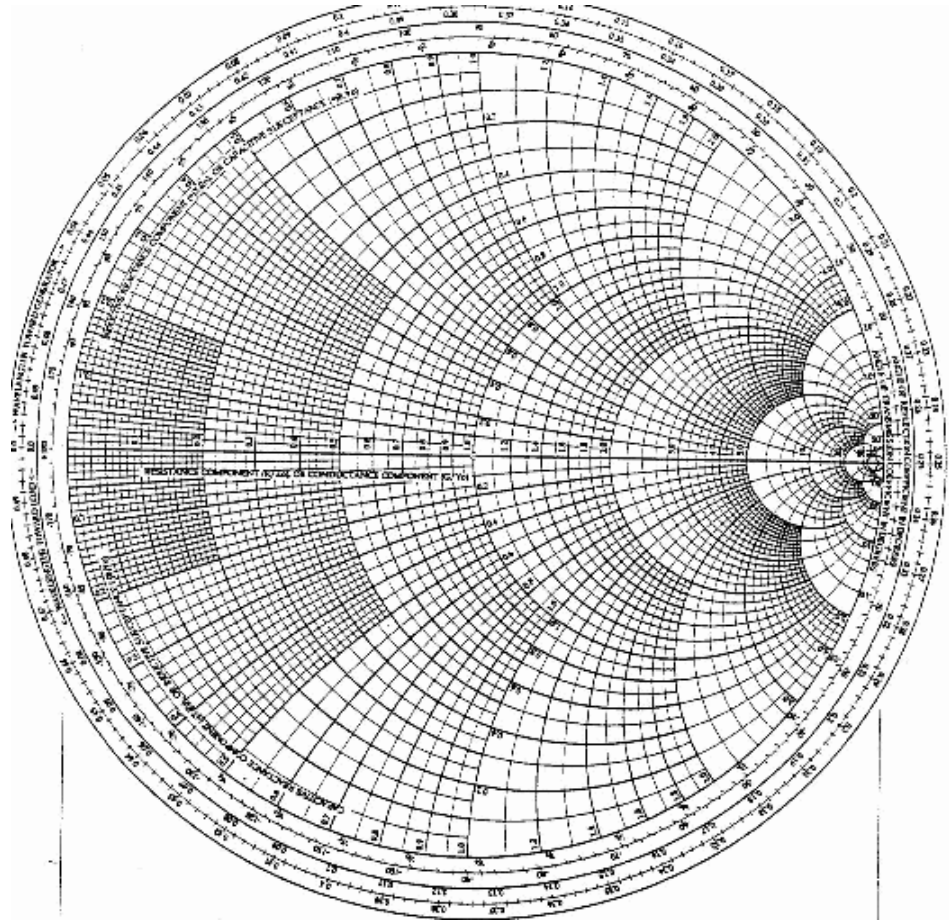
$$\Delta = |S_{11}S_{22} - S_{12}S_{21}|$$

- If $K > 1$ and $|\Delta| < 1$, then the circuit is unconditionally stable for any combination of input and output impedances.

Smith chart



Philip H Smith
(1905 – 1987)



Smith chart

- The Smith chart is one of the most useful graphical tools for high frequency circuit applications.
- The goal of the Smith chart is to identify all possible impedances on the domain of existence of the reflection coefficient.

$$Z(d) = \frac{V(d)}{I(d)} = Z_0 \frac{1 + \Gamma(d)}{1 - \Gamma(d)} \quad \Gamma = \frac{Z_L - Z_0}{Z_L + Z_0}$$

- "Normalized reflection coefficient": $Z(d) = Z_0 * z(d)$

Smith chart

$$Z = R \pm j X$$

Impedance

The chart is normalized (Z_n) so that any characteristic impedance (Z_0) can be used.

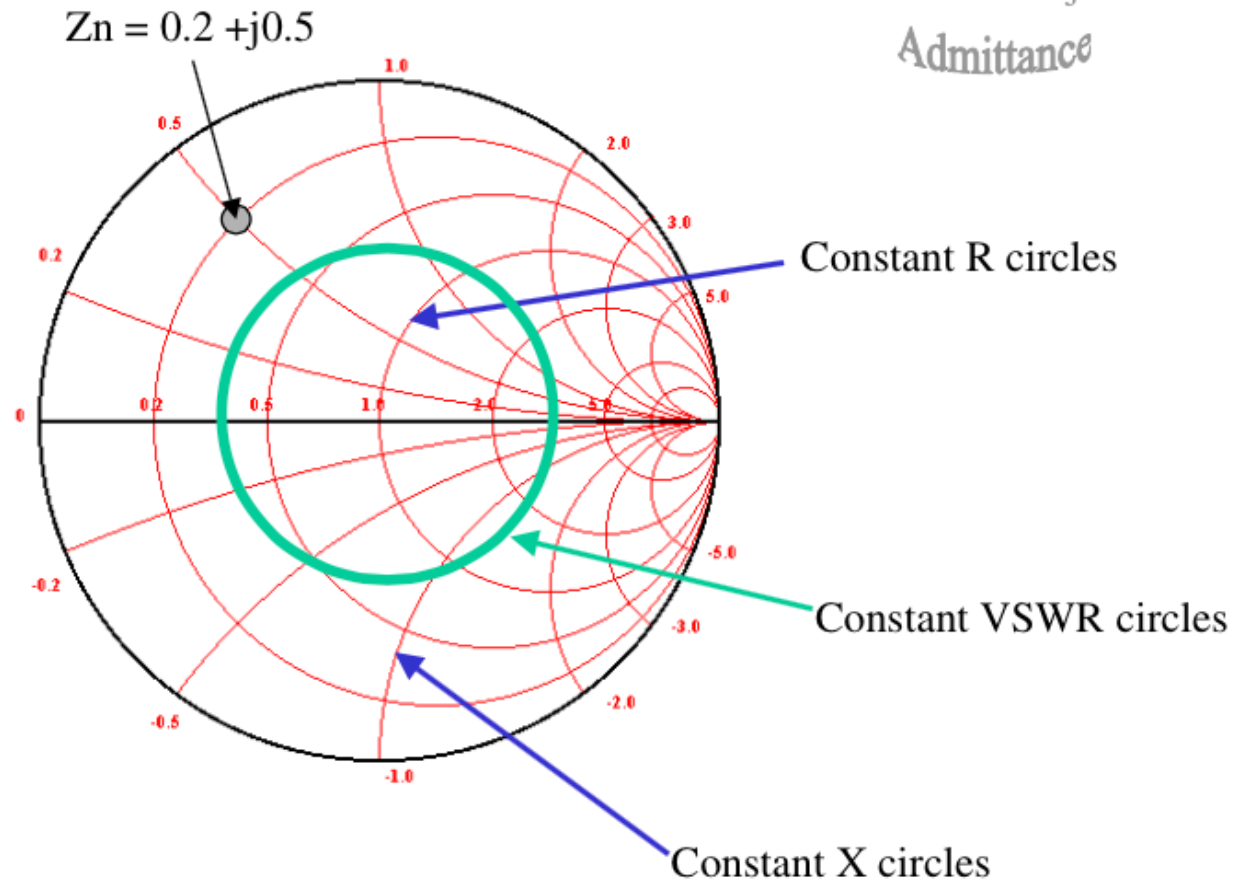
$$Z_n = \frac{R}{Z_0} \pm j \frac{X}{Z_0}$$

$$VSWR = \frac{|V_{\max}|}{|V_{\min}|} = \frac{1 + |\Gamma|}{1 - |\Gamma|}$$

"mismatch"

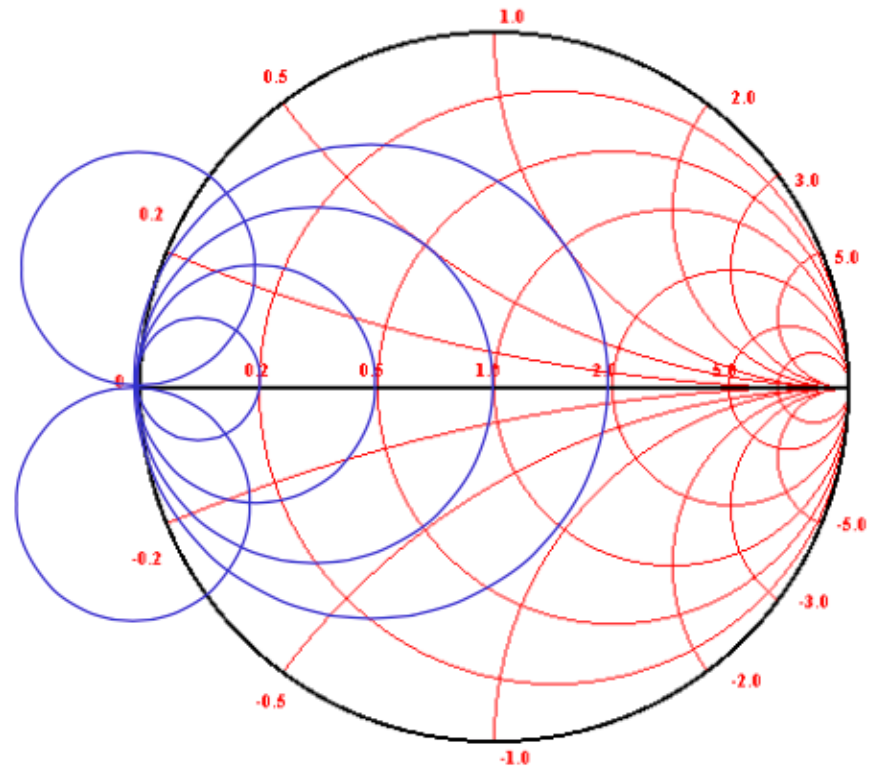
$$Y = G \pm j B$$

Admittance



Smith chart

- There's also a mirror image of the chart that instead of having constant resistance circles, and constant reactance curves, has instead constant conductance circles and constant susceptance curves.





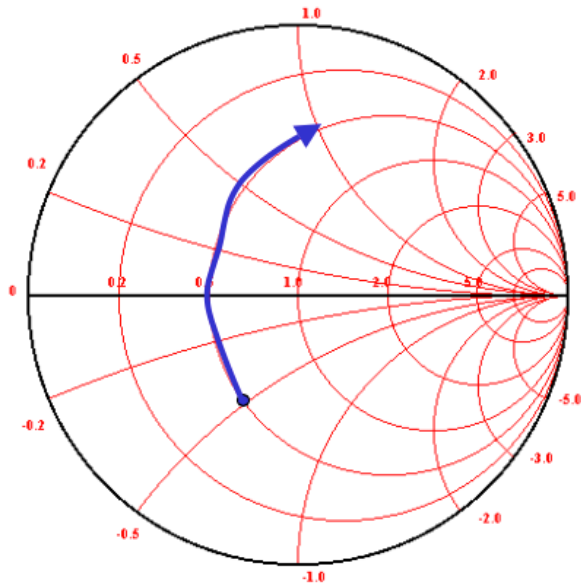
Smith Chart applications

- Plotting/displaying impedances, e.g. as a function of frequency.
- Matching (impedance transformation)
- Determine VSWR
-

L in the Smith chart

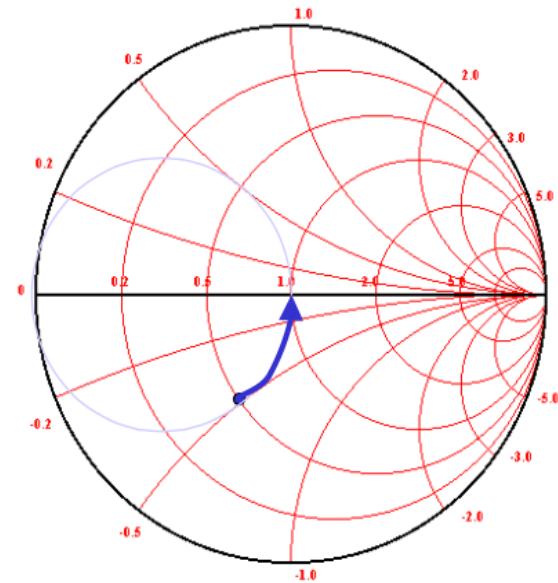
Series Inductors

Moves clockwise along circles of constant **resistance**



Shunt Inductors

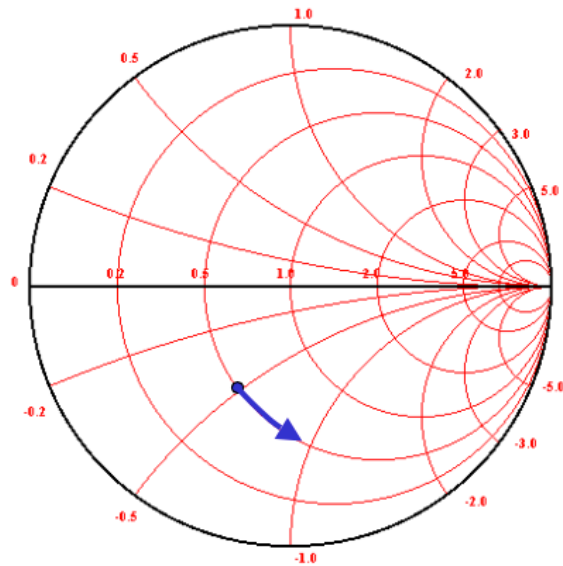
Moves counter-clockwise along circles of constant **conductance**



C in the Smith chart

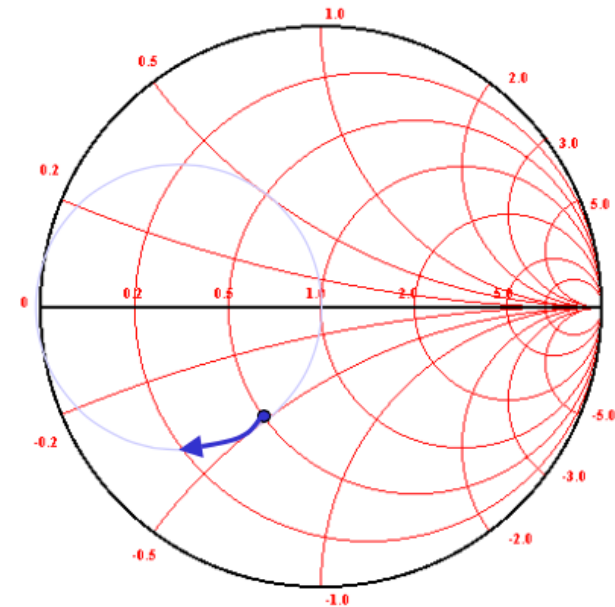
Series Capacitors

Moves counter-clockwise along circles of constant **resistance**



Shunt Capacitors

Moves clockwise along circles of constant **conductance**



Matching using Smith chart

Let's do some matching with L's and C's

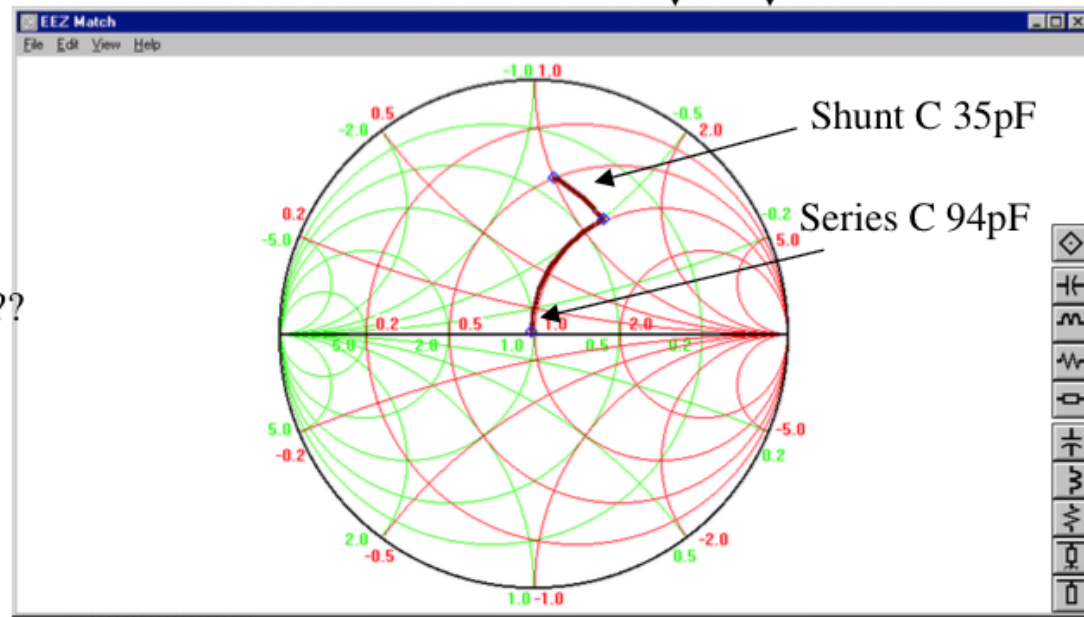
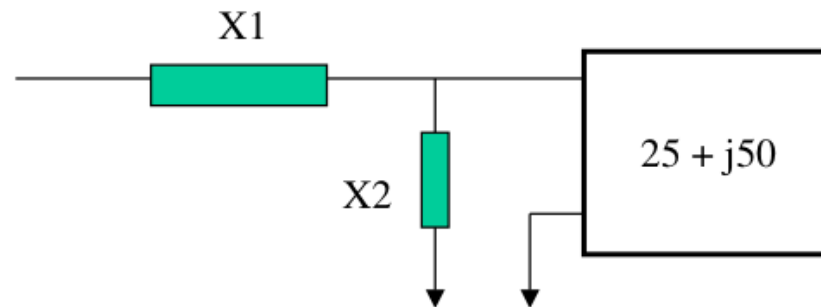
Pick Z_0 (50 Ohms sounds OK...)

Frequency is 28 MHz

The shunt Cap, transforms the R part of the Z to 1 (on the unit R circle..) from there a simple series C will take out the inductive reactance..

Easy as π

Are there other ways to match this same impedance??



Matching using Smith chart

